

SMD NTC thermistor for semiconductor power modules

 Series/Type:
 B57621C5502H062

 Ordering code:
 14.04.2022

 Version:
 4



B57621C5502H062

SMD NTC thermistor for semiconductor power modules

Applications

Temperature measurement for semiconductor power modules

- Threshold temperature measurement
- DCB & PCB temperature measurement
- Heat sink temperature monitoring

Features

- Multilayer SMD NTC thermistor with nickel barrier termination (AgNiSn)
- B values specified between 25 °C and 100 °C for highest accuracy at typical working temperature
- Minimized resistance drift after soldering process
- Excellent long-term aging stability in high temperature and high humidity environment
- UL approval (E69802)
- RoHS compliant without exemption
- 100% lead-free

Electrical specifications

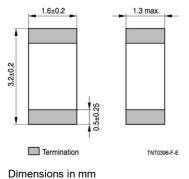
Ordering code	Zero-power resistance (at 25 °C)	B _{25/100}	B _{25/85}	B _{25/50}
B57621C5502H062	5 kΩ ±3%	3455 K ±2%	(3420 K)	(3375 K)

General technical data

Operating temperature range	T _{op}	-40 175	°C
Maximum power @ 25 °C on PCB	P ₂₅ ¹⁾	50	mW
Rated temperature	T _R	25	°C
Dissipation factor on PCB	$\delta_{th}^{1)}$	approx. 5	mW/K
Thermal cooling time constant on PCB	$\tau_c^{1)}$	approx. 10	s
Heat capacity	$C_{th}^{1)}$	approx. 50	mJ/K
Weight of component		approx. 18	mg

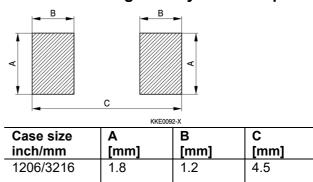
¹⁾ Depends on mounting situation.

Dimensional drawing for case size 1206



PPD ML PD

Recommended geometry of solder pads





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Reliability data

Tests of SMD NTC thermistors are based on AEC-Q200 Rev-D. The parts are mounted on standardized PCB.

Test	Standard	Test conditions	ΔR ₂₅ / R ₂₅ (typical)	Remarks
Pre- and post-stress electrical test		Resistance at: 25 °C and 100 °C	-	
High temperature exposure (storage)	MIL-STD-202, method 108	Test temperature: 150 °C Duration: 1000 h Unpowered	< 5%	
Temperature cycling	JESD22, method JA-104	Lower test temperature: -40 °C Upper test temperature: 150 °C Number of cycles: 1000 Dwell time: 15 min	< 5%	
Biased humidity	MIL-STD-202, method 103	Test temperature: 85 °C Rel. humidity of air: 85% Duration: 1000 h Test voltage: V _{NTC} = 0.3 V DC	< 5%	
Operational life	MIL-STD-202, method 108	Test temperature: 150 °C P _{max} = 0.35 mW Duration: 1000 h	< 5%	
External visual	MIL-STD-883E, method 2009	Visual inspection		
Physical dimensions	JESD22, method JB-100	Measured with calibers		Within the specified values
Resistance to solvents	MIL-STD-202, method 215	Not applicable for SMD NTC therm (component has no marking, color		ating)
Mechanical shock	MIL-STD-202, method 213	Peak value: 1500 <i>g</i> Half sine Condition F	< 5%	
Vibration	MIL-STD-202, method 204	Acceleration: 5 <i>g</i> Sweep time: 20 min Frequency range: 10 … 2000 Hz 3 x 12 cycles	< 5%	
Resistance to soldering heat	MIL-STD-202, method 210	Dip: 260 °C; 10 s 1 heat cycle	< 5%	



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Test	Standard	Test conditions	$\Delta R_{25} / R_{25}$ (typical)	Remarks
ESD	AEC-Q200-002, method -002	Discharge capacitance: 150 pF Discharge resistance: 2 kΩ Charging voltage: 6 kV Contact discharge	< 5%	
		2 pulses in each polarity		
Solderability	J-STD-002	 a) Dip: 235 °C; 5 s: aging 4 h @ 155 °C b) Dip: 215 °C; 5 s: steam aging 8 h @ 92 °C c) Dip: 260 °C; 7 s: steam aging 8 h @ 92 °C 		95% of termination wetted
Electrical characterization		R(25 °C), R(100 °C), B(25/100)		Within the specified values
Flammability	UL-94,	Not applicable for SMD NTC thermis	stors	
	V-0 or V-1	(component is not coated or encaps	ulated with p	lastic materials)
Board flex	AEC-Q200-005, method -005	Max. bending: 2 mm Duration @ max. bending: 60 s	< 5%	
Terminal strength	AEC-Q200-006, method -006	Max. F: 17.7 N	< 5%	
Resistance drift after soldering		Reflow soldering profile Wave soldering profile	< 1%	

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NTC thermistors for temperature measurement

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R/T characteristics

NTC resistance temperature curve

R/T-curve	N/A
R at 25 °C	5000 [Ω]
B (25/100)	3455 [K] ±2.0 [%]
R _N at 25 °C	5000 [Ω] ±3.0 [%]

Temp. [°C]	R Nom [Ω]	R Min [Ω]	R Max [Ω]	∆T [±°C]	α [%/K]
85	731.92	683.20	783.42	2.6	2.7
86	712.27	664.50	762.78	2.6	2.7
87	693.23	646.40	742.79	2.6	2.7
88	674.79	628.87	723.42	2.7	2.7
89	656.94	611.91	704.64	2.7	2.7
90	639.64	595.49	686.44	2.7	2.7
91	622.87	579.58	668.79	2.8	2.7
92	606.63	564.17	651.69	2.8	2.6
93	590.88	549.25	635.10	2.8	2.6
94	575.62	534.79	619.01	2.9	2.6
95	560.82	520.78	603.40	2.9	2.6
96	546.48	507.20	588.26	3.0	2.6
97	532.57	494.04	573.57	3.0	2.6
98	519.07	481.29	559.32	3.0	2.6
99	505.99	468.92	545.49	3.1	2.6
100	493.29	456.93	532.06	3.1	2.5
101	480.97	445.30	519.03	3.1	2.5
102	469.02	434.02	506.38	3.2	2.5
103	457.41	423.08	494.09	3.2	2.5
104	446.15	412.46	482.16	3.2	2.5
105	435.22	402.17	470.57	3.3	2.5
106	424.61	392.17	459.31	3.3	2.5
107	414.30	382.47	448.38	3.3	2.5
108	404.29	373.06	437.75	3.4	2.4
109	394.57	363.92	427.43	3.4	2.4
110	385.13	355.04	417.40	3.5	2.4
111	375.96	346.43	407.64	3.5	2.4
112	367.05	338.06	398.17	3.5	2.4
113	358.39	329.93	388.95	3.6	2.4
114	349.97	322.03	379.99	3.6	2.4
115	341.79	314.36	371.28	3.6	2.4

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Temp. [°C]	R Nom [Ω]	R Min [Ω]	R Max [Ω]	∆T [±°C]	α [%/K]
116	333.84	306.91	362.80	3.7	2.4
117	326.11	299.67	354.56	3.7	2.3
118	318.59	292.63	346.54	3.8	2.3
119	311.28	285.79	338.74	3.8	2.3
120	304.17	279.14	331.16	3.8	2.3
121	297.26	272.67	323.77	3.9	2.3
122	290.53	266.39	316.58	3.9	2.3
123	283.99	260.27	309.59	4.0	2.3
124	277.62	254.33	302.78	4.0	2.3
125	271.43	248.54	296.15	4.0	2.3
126	265.40	242.92	289.70	4.1	2.2
127	259.53	237.45	283.41	4.1	2.2
128	253.82	232.12	277.29	4.2	2.2
129	248.26	226.94	271.33	4.2	2.2
130	242.84	221.90	265.53	4.2	2.2
131	237.57	216.99	259.87	4.3	2.2
132	232.44	212.21	254.36	4.3	2.2
133	227.44	207.56	248.99	4.4	2.2
134	222.57	203.03	243.76	4.4	2.2
135	217.82	198.62	238.66	4.4	2.2
136	213.20	194.32	233.69	4.5	2.1
137	208.69	190.14	228.85	4.5	2.1
138	204.30	186.07	224.13	4.6	2.1
139	200.03	182.10	219.52	4.6	2.1
140	195.86	178.23	215.03	4.6	2.1
141	191.79	174.46	210.66	4.7	2.1
142	187.83	170.79	206.39	4.7	2.1
143	183.97	167.21	202.22	4.8	2.1
144	180.20	163.72	198.16	4.8	2.1
145	176.53	160.32	194.20	4.9	2.1
146	172.95	157.01	190.33	4.9	2.0
147	169.45	153.78	186.56	4.9	2.0
148	166.05	150.63	182.88	5.0	2.0
149	162.72	147.56	179.29	5.0	2.0
150	159.48	144.56	175.78	5.1	2.0
151	156.31	141.64	172.36	5.1	2.0
152	153.23	138.79	169.02	5.2	2.0
153	150.21	136.00	165.76	5.2	2.0
154	147.27	133.29	162.57	5.3	2.0

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Temp. [°C]	R Nom [Ω]	R Min [Ω]	R Max [Ω]	∆T [±°C]	α [%/K]
155	144.40	130.64	159.46	5.3	2.0
156	141.60	128.06	156.42	5.3	2.0
157	138.86	125.54	153.46	5.4	2.0
158	136.19	123.08	150.56	5.4	1.9
159	133.58	120.68	147.73	5.5	1.9
160	131.03	118.33	144.97	5.5	1.9
161	128.54	116.04	142.26	5.6	1.9
162	126.11	113.81	139.62	5.6	1.9
163	123.74	111.62	137.05	5.7	1.9
164	121.42	109.49	134.53	5.7	1.9
165	119.15	107.41	132.06	5.8	1.9
166	116.94	105.38	129.65	5.8	1.9
167	114.78	103.39	127.30	5.8	1.9
168	112.66	101.45	125.00	5.9	1.9
169	110.60	99.56	122.75	5.9	1.9
170	108.58	97.70	120.55	6.0	1.8
171	106.60	95.89	118.40	6.0	1.8
172	104.67	94.13	116.30	6.1	1.8
173	102.79	92.40	114.24	6.1	1.8
174	100.94	90.71	112.23	6.2	1.8
175	99.14	89.06	110.26	6.2	1.8

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NTC thermistors for temperature measurement

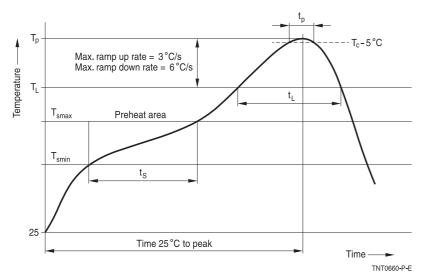
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Recommended soldering profiles

Reflow soldering

Temperature ranges for reflow soldering acc. To IEC 60068-2-58 recommendations.



Profile feature		Sn-Pb eutectic assembly	Pb-free assembly
Preheat and soak			
- Temperature min	T _{smin}	100 °C	150 °C
- Temperature max	T _{smax}	150 °C	200 °C
- Time	$t_{\text{smin}} \text{ to } t_{\text{smax}}$	60 120 s	60 120 s
Average ramp-up rate	T_{smax} to T_p	3 °C/ s max.	3 °C/ s max.
Liquidous temperature	T∟	183 °C	217 °C
Time at liquidous	t∟	40 … 150 s	40 … 150 s
Peak package body temperature	T _p ¹⁾	215 °C 260 °C	235 °C 260 °C
Time above (Tp -5 $^\circ C$)	tp	10 40 s	10 40 s
Average ramp-down rate	T_p to T_{smax}	6 °C/ s max.	6 °C/ s max.
Time 25 °C to peak temperature		max. 8 minutes	max. 8 minutes

1) Depending on package thickness.

Note: All temperatures refer to topside of the package, measured on the package body surface. Number of reflow cycles: 3

Iron soldering should be avoided hot air methods are recommended for repair purposes.

Recommended solder

Flux less Pb-free Sn (95.1 ... 96.0), Ag (3.0 ... 4.0), Cu (0.5 ... 0.9) solder is recommended.



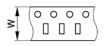
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Taping and packing

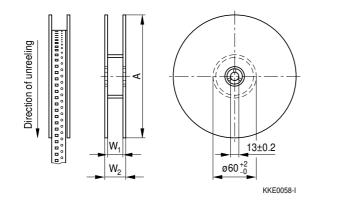
Tape and reel packing according to IEC 60286-3 Tape material: Blister

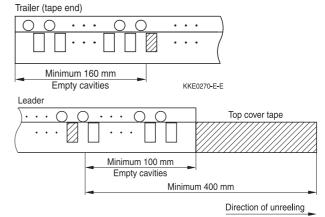
Tape dimensions and tolerances



Definition	Symbol	Dimension [mm]	Tolerance [mm]
Tape width	W	8.00	±0.30

Reel dimensions and tolerances





KKE0289-Q-E

Definition	Symbol	Dimension [mm]	Tolerance [mm]
Reel diameter	A	180	+0/-3
Reel width (inside)	W1	8.4	+1.5/-0
Reel width (outside)	W2	14.4	max.

Packing unit: 4000 pcs./ reel



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Cautions and warnings

Storage

- Store thermistors only in original packaging. Do not open the package before storage.
- Storage conditions in original packaging: storage temperature –25 °C …+45 °C, relative humidity ≤75% annual mean, 95% on max. 30 days in a year, dew precipitation and wetness are inadmissible.
- Do not store SMDs where they are exposed to heat or direct sunlight. Otherwise, the packing material
 may be deformed or SMDs may stick together, causing problems during mounting.
- Avoid contamination of thermistors surface during storage, handling and processing. Touching the
 metallization of unsoldered thermistors may change their soldering properties.
- Avoid storage of thermistor in harmful environments like corrosive gases (SO_x, CI etc.)
- After opening the factory seals, such as polyvinyl-sealed packages, use the SMDs as soon as possible.
- Solder thermistors after shipment from TDK Electronics within the time specified: SMD NTC thermistors with nickel-barrier termination: 12 months

Handling

- NTC thermistors must not be dropped. Chip-offs must not be caused during handling of NTCs.
- Components must not be touched with bare hands. Gloves are recommended.
- Avoid contamination of thermistor surface during handling.
- Washing processes may damage the product due to the possible static or cyclic mechanical loads (e.g. ultrasonic cleaning). They may cause cracks to develop on the product and its parts, which might lead to reduced reliability or lifetime.

Soldering

- Use resin-type flux or non-activated flux.
- Insufficient preheating may cause ceramic cracks.
- Rapid cooling by dipping in solvent is not recommended.
- Complete removal of flux is recommended.

Mounting

- When NTC thermistors are encapsulated with sealing material or over molded with plastic material, there
 must be no mechanical stress caused by thermal expansion during the production process (curing / over
 molding process) and during later operation. The upper category temperature of the thermistor must not
 be exceeded. Ensure that the materials used (sealing compound and plastic material) are chemically
 neutral.
- Electrode must not be scratched before/during/after the mounting process.
- Contacts and housing used for assembly with thermistor have to be clean before mounting.
- Ensure that adjacent materials are designed for operation at temperatures comparable to the surface temperature of the thermistor. Be sure that surrounding parts and materials can withstand the temperature.
- Avoid contamination of thermistor surface during processing.

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NTC thermistors for temperature measurement

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Operation

- Use thermistors only within the specified operating temperature range.
- Environmental conditions must not harm the thermistors. Use thermistors only in normal atmospheric conditions.
- Contact of NTC thermistors with any liquids and solvents should be prevented. It must be ensured that no
 water enters the NTC thermistors (e.g. through plug terminals). For measurement purposes (checking the
 specified resistance vs. temperature), the component must not be immersed in water but in suitable
 liquids (e.g. Galden).
- Avoid dewing and condensation.
- Be sure to provide an appropriate fail-safe function to prevent secondary product damage caused by malfunction (e.g. use VDR for limitation of overvoltage condition).

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Release 2020-06